

Silicon Carbide Power MOSFET N-Channel Enhancement Mode

Features

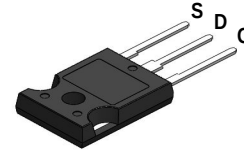
- 3rd generation SiC MOSFET technology
- High blocking voltage with low On-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant

Typical Applications

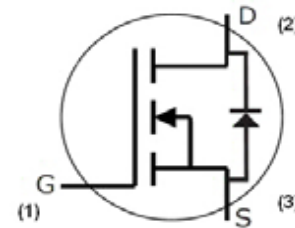
- Solar inverters
- EV motor drive
- High voltage DC/DC converters
- Switched mode power supplies

Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency



T0-247-3



ORDERING INFORMATION

HT63N1200ADZ

$T_A = -40^\circ \text{ to } 175^\circ \text{ C}$ for all packages

Key Parameters

Parameter	Symbol	Min.	Typ.	Max	Unit	Conditions	Note
Drain - Source Voltage	V_{DS}			1200	V	$T_c = 25^\circ \text{C}$	
Maximum Gate - Source Voltage	$V_{GS(max)}$	-8		+19		Transient	
Operational Gate-Source Voltage	$V_{GS op}$		-4/15			Static	Note 1
DC Continuous Drain Current	I_D			63	A	$V_{GS} = 15 \text{ V}, T_c = 25^\circ \text{C}, T_J \leq 175^\circ \text{C}$	Fig. 19 Note 2
				48		$V_{GS} = 15 \text{ V}, T_c = 100^\circ \text{C}, T_J \leq 175^\circ \text{C}$	
Pulsed Drain Current	I_{DM}			120		t_{Pmax} limited by T_{Jmax} $V_{GS} = 15 \text{ V}, T_c = 25^\circ \text{C}$	Fig. 22
Power Dissipation	P_D			283	W	$T_c = 25^\circ \text{C}, T_J = 175^\circ \text{C}$	Fig. 20
Operating Junction and Storage Temperature	T_J, T_{stg}			-40 to +175	$^\circ \text{C}$		
Solder Temperature	T_L			260		According to JEDEC J-STD-020	
Mounting Torque	M_D			1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): Recommended turn-on gate voltage is 15V with $\pm 5\%$ regulation tolerance, see Application Note PRD-04814 for additional details

Note (2): Verified by design

Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	Note
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	1200	—	—	V	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	Fig. 11
Gate Threshold Voltage	$V_{GS(th)}$	1.8	2.5	3.6		$V_{DS} = V_{GS}, I_D = 11.5\text{ mA}$	
		—	2.0	—		$V_{DS} = V_{GS}, I_D = 11.5\text{ mA}, T_J = 175^\circ\text{C}$	
Zero Gate Voltage Drain Current	I_{DSS}	—	1	50	μA	$V_{DS} = 1200\text{ V}, V_{GS} = 0\text{ V}$	
Gate-Source Leakage Current	I_{GSS}	—	10	250	nA	$V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$	
Drain-Source On-State Resistance	$R_{DS(on)}$	23	32	43	m Ω	$V_{GS} = 15\text{ V}, I_D = 40\text{ A}$	Fig. 4, 5, 6
		—	57.6	—		$V_{GS} = 15\text{ V}, I_D = 40\text{ A}, T_J = 175^\circ\text{C}$	
Transconductance	g_{fs}	—	27	—	S	$V_{DS} = 20\text{ V}, I_{DS} = 40\text{ A}$	Fig. 7
			22			$V_{DS} = 20\text{ V}, I_{DS} = 40\text{ A}, T_J = 175^\circ\text{C}$	
Input Capacitance	C_{iss}	—	3357	—	pF	$V_{GS} = 0\text{ V},$ $V_{DS} = 1000\text{ V}$ $f = 100\text{ kHz}$ $V_{AC} = 25\text{ mV}$	Fig. 17, 18
Output Capacitance	C_{oss}	—	129	—			
Reverse Transfer Capacitance	C_{rss}	—	8	—			
C_{oss} Stored Energy	E_{oss}	—	76	—	μJ		Fig. 16
Turn-On Switching Energy (SiC Diode FWD)	E_{on}	—	1.94	—	mJ	$V_{DS} = 800\text{ V}, V_{GS} = -4/+15\text{ V}, I_D = 40\text{ A},$ $R_{G(ext)} = 5\text{ }\Omega, L = 157\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$	Fig. 26
Turn Off Switching Energy (SiC Diode FWD)	E_{off}	—	0.79	—			
Turn-On Switching Energy (Body Diode FWD)	E_{on}	—	3.10	—			
Turn Off Switching Energy (Body Diode FWD)	E_{off}	—	0.72	—			
Turn-On Delay Time	$t_{d(on)}$	—	107	—	ns	$V_{DS} = 800\text{ V}, V_{GS} = -4/15\text{ V}$ $R_{G(ext)} = 5\text{ }\Omega, I_D = 40\text{ A}, L = 157$ Timing relative to V_{DS} , Inductive load	Fig. 27
Rise Time	t_r	—	22	—			
Turn-Off Delay Time	$t_{d(off)}$	—	39	—			
Fall Time	t_f	—	19	—			
Internal Gate Resistance	$R_{G(int)}$	—	1.7	—	Ω	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	
Gate to Source Charge	Q_{gs}	—	35	—	nC	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 40\text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12
Gate to Drain Charge	Q_{gd}	—	40	—			
Total Gate Charge	Q_g	—	114	—			

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Typ.	Max.	Unit	Test Conditions	Note
Diode Forward Voltage	V_{SD}	4.6	—	V	$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		4.2	—		$V_{GS} = -4\text{ V}, I_{SD} = 20\text{ A}, T_J = 175^\circ\text{C}$	
Continuous Diode Forward Current	I_S	—	62	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	
Diode Pulse Current	I_{SM}	—	120		$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$, pulse width limited by T_{jmax}	
Reverse Recover Time	t_{rr}	69	—	nS	$V_{GS} = -4\text{ V}, I_{SD} = 40\text{ A}, V_R = 800\text{ V}$ $di_F/dt = 1500\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Reverse Recovery Charge	Q_{rr}	848	—	nC		
Peak Reverse Recovery Current	I_{rrm}	19	—	A		

Thermal Characteristics

Parameter	Symbol	Typ.	Unit	Note
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.45	$^\circ\text{C}/\text{W}$	Fig. 21
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	40		

Typical Performance

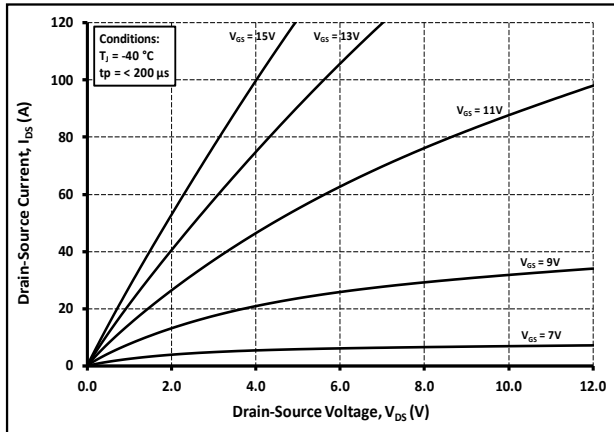


Figure 1. Output Characteristics $T_j = -40^\circ\text{C}$

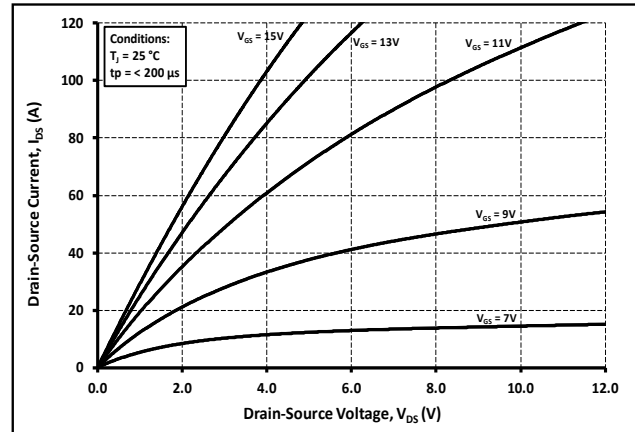


Figure 2. Output Characteristics $T_j = 25^\circ\text{C}$

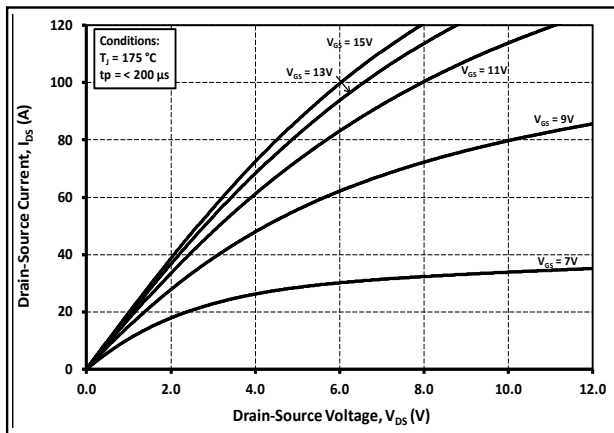


Figure 3. Output Characteristics $T_j = 175^\circ\text{C}$

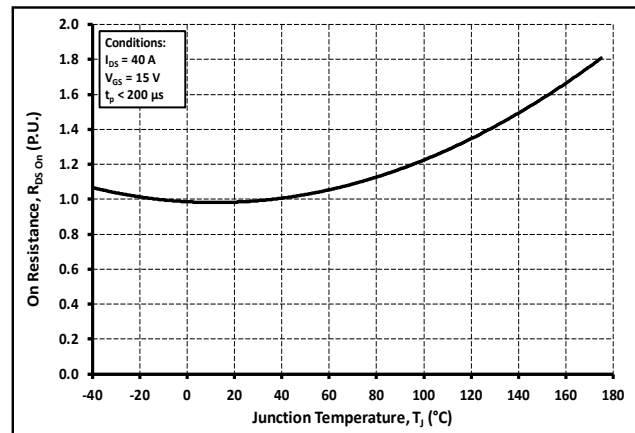


Figure 4. Normalized On-Resistance vs. Temperature

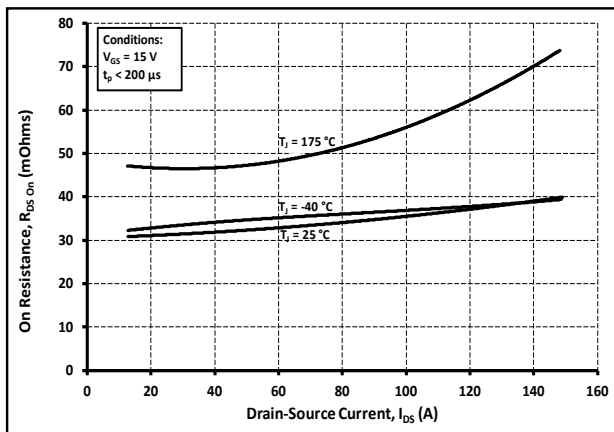


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

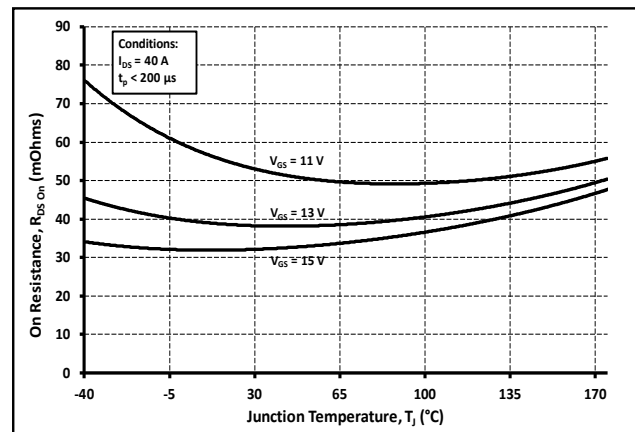


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

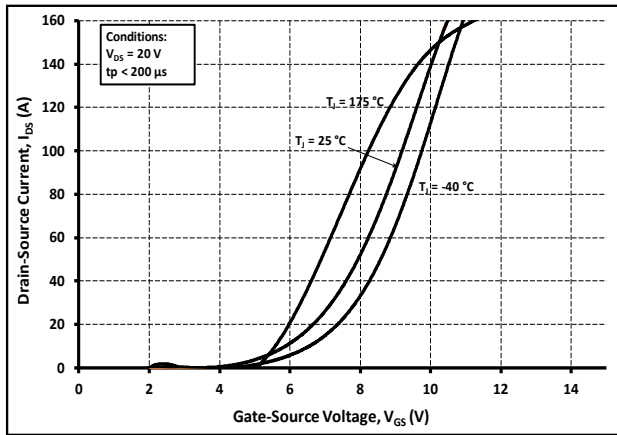


Figure 7. Transfer Characteristic for Various Junction Temperatures

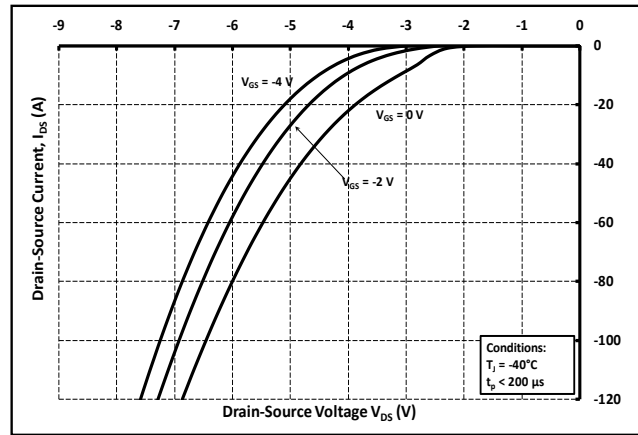


Figure 8. Body Diode Characteristic at -40°C

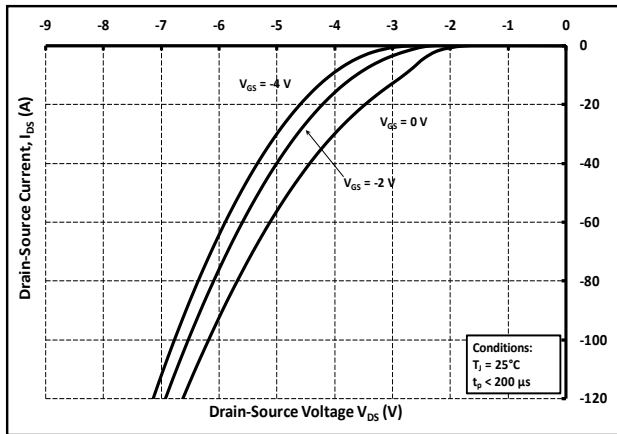


Figure 9. Body Diode Characteristic at 25°C

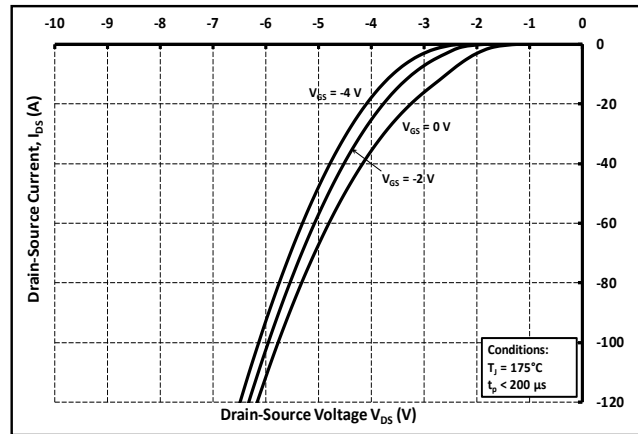


Figure 10. Body Diode Characteristic at 175°C

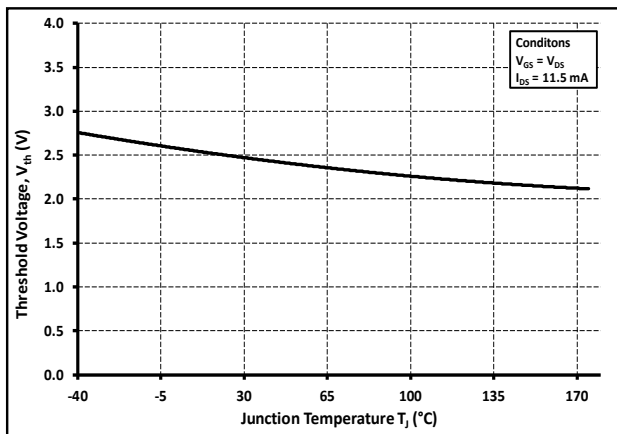


Figure 11. Threshold Voltage vs. Temperature

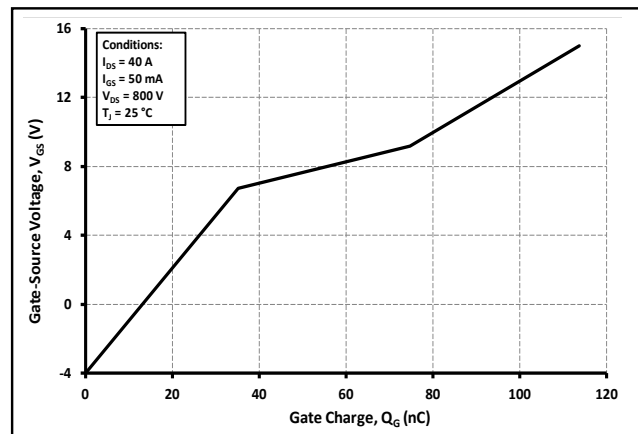


Figure 12. Gate Charge Characteristics

Typical Performance

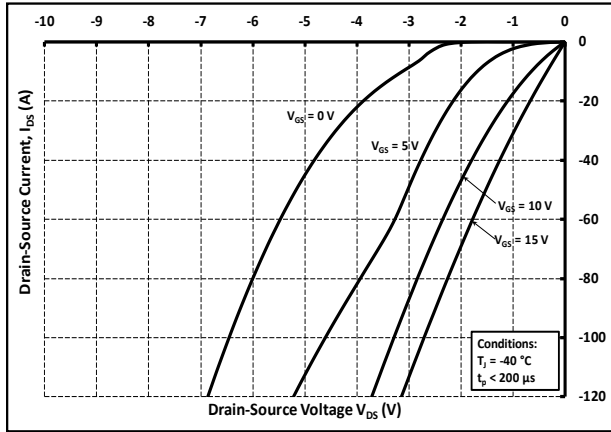


Figure 13. 3rd Quadrant Characteristic at -40°C

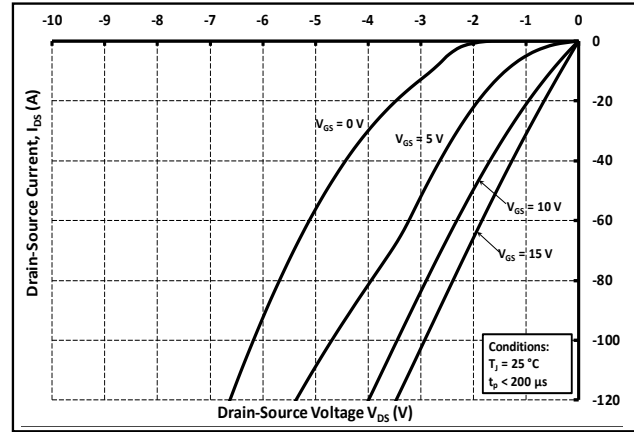


Figure 14. 3rd Quadrant Characteristic at 25°C

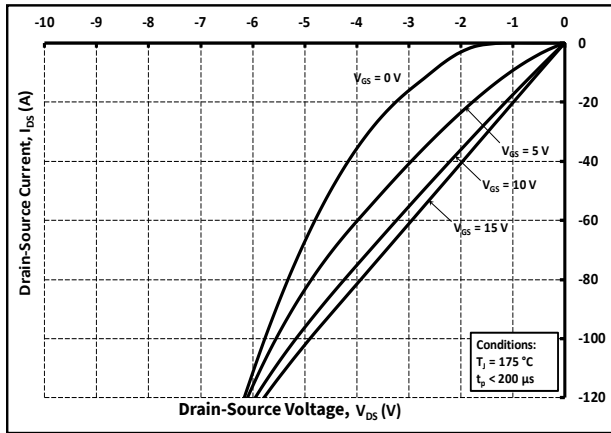


Figure 15. 3rd Quadrant Characteristic at 175°C

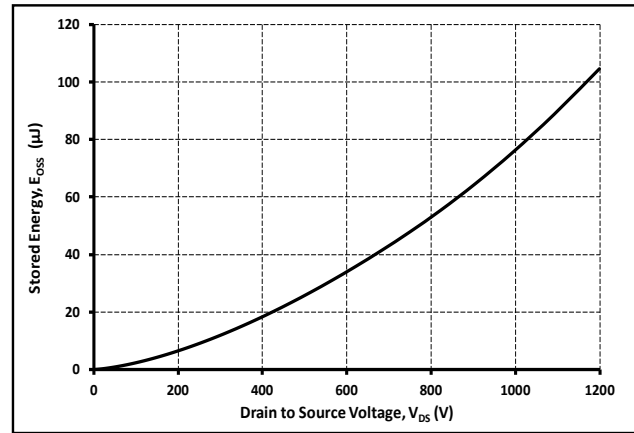


Figure 16. Output Capacitor Stored Energy

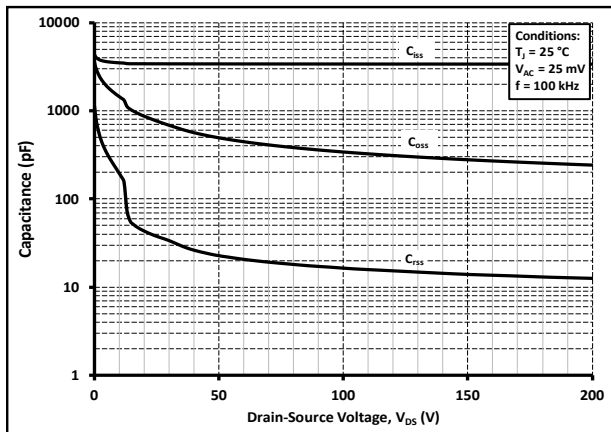


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200 V)

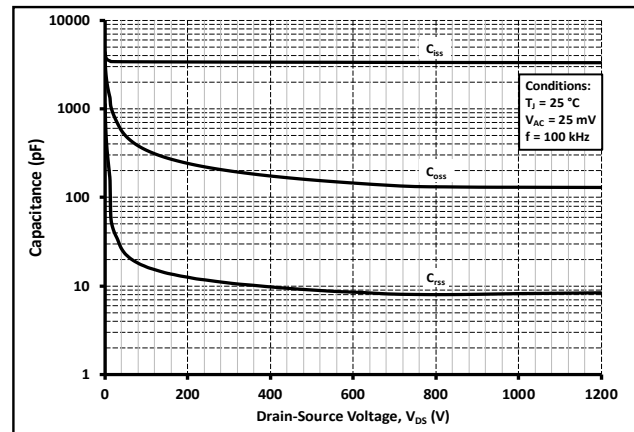


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200 V)

Typical Performance

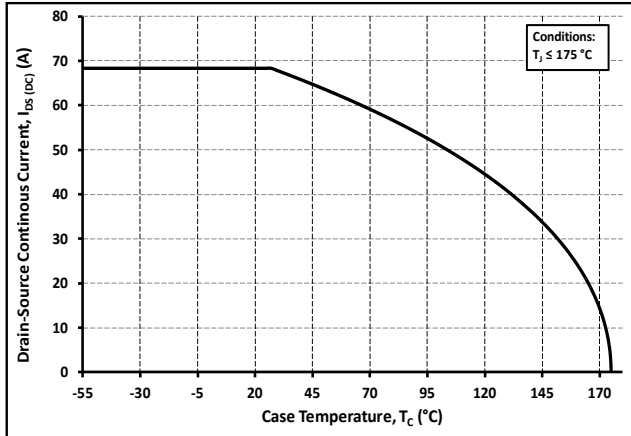


Figure 19. Continuous Drain Current Derating vs. Case Temperature

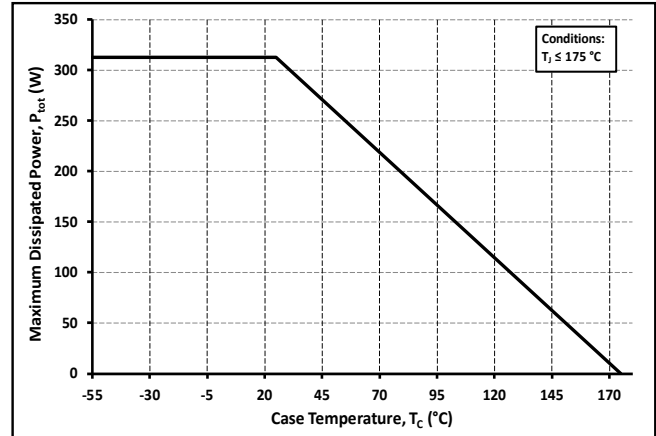


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

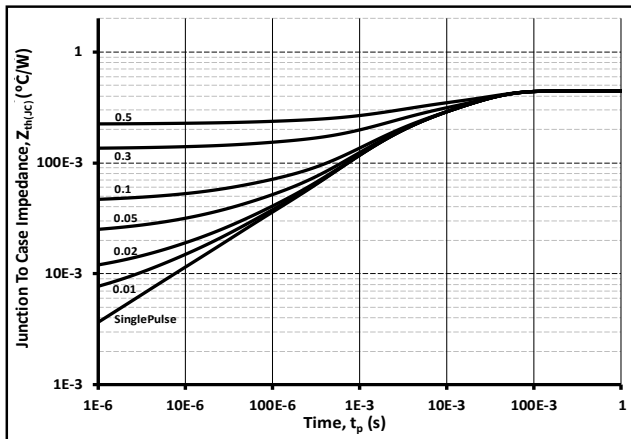


Figure 21. Transient Thermal Impedance (Junction - Case)

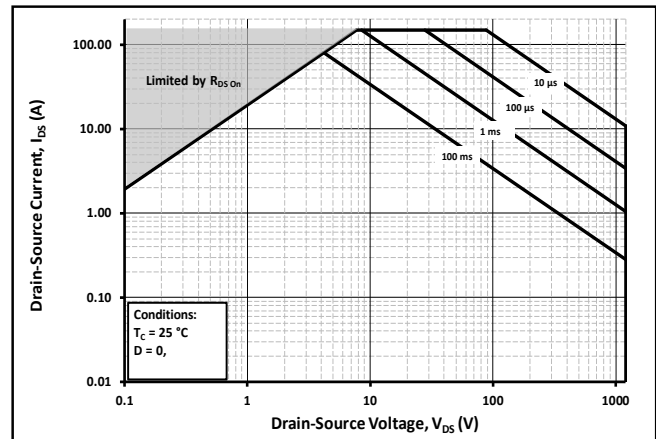


Figure 22. Safe Operating Area

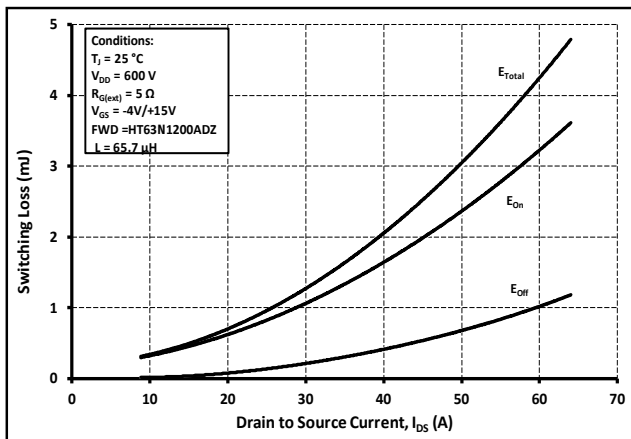


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600\text{V}$)

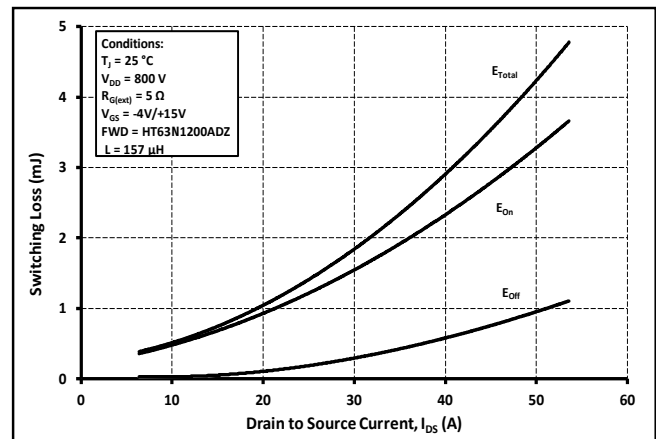


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 800\text{V}$)

Typical Performance

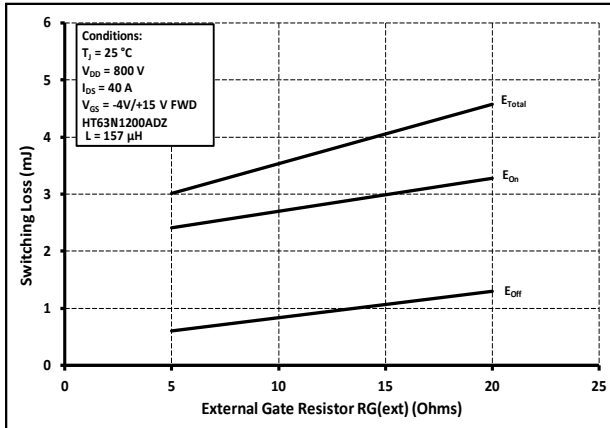


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

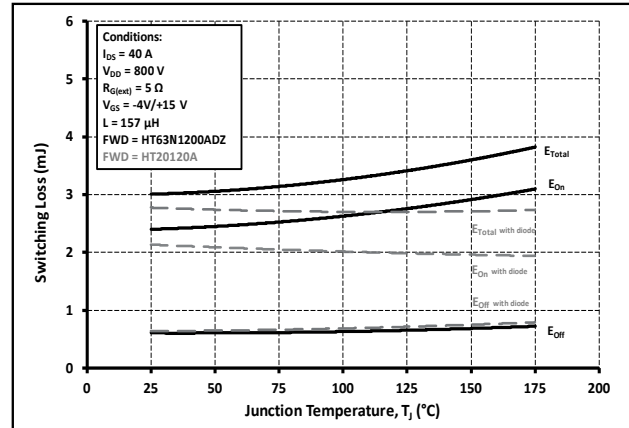


Figure 26. Clamped Inductive Switching Energy vs. Temperature

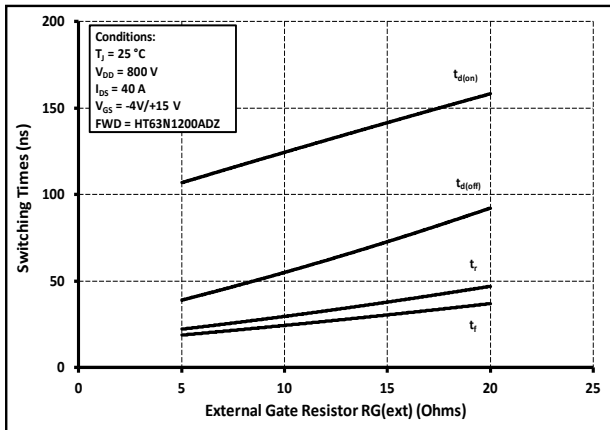


Figure 27. Switching Times vs. $R_{G(ext)}$

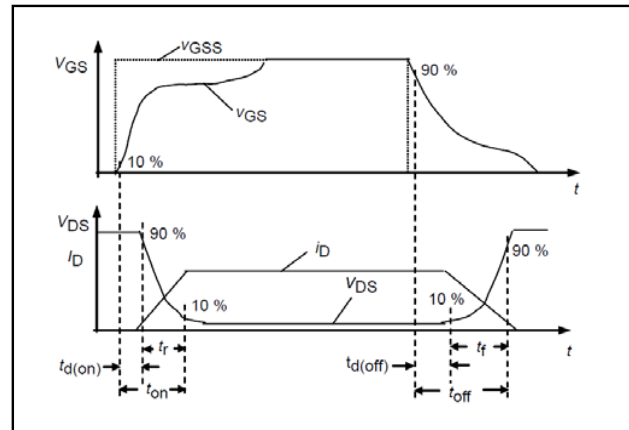


Figure 28. Switching Times Definition

Test Circuit Schematic

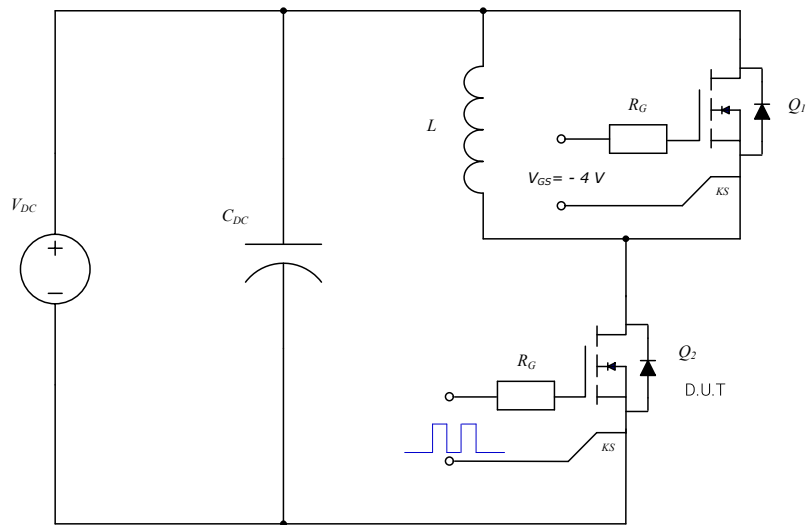
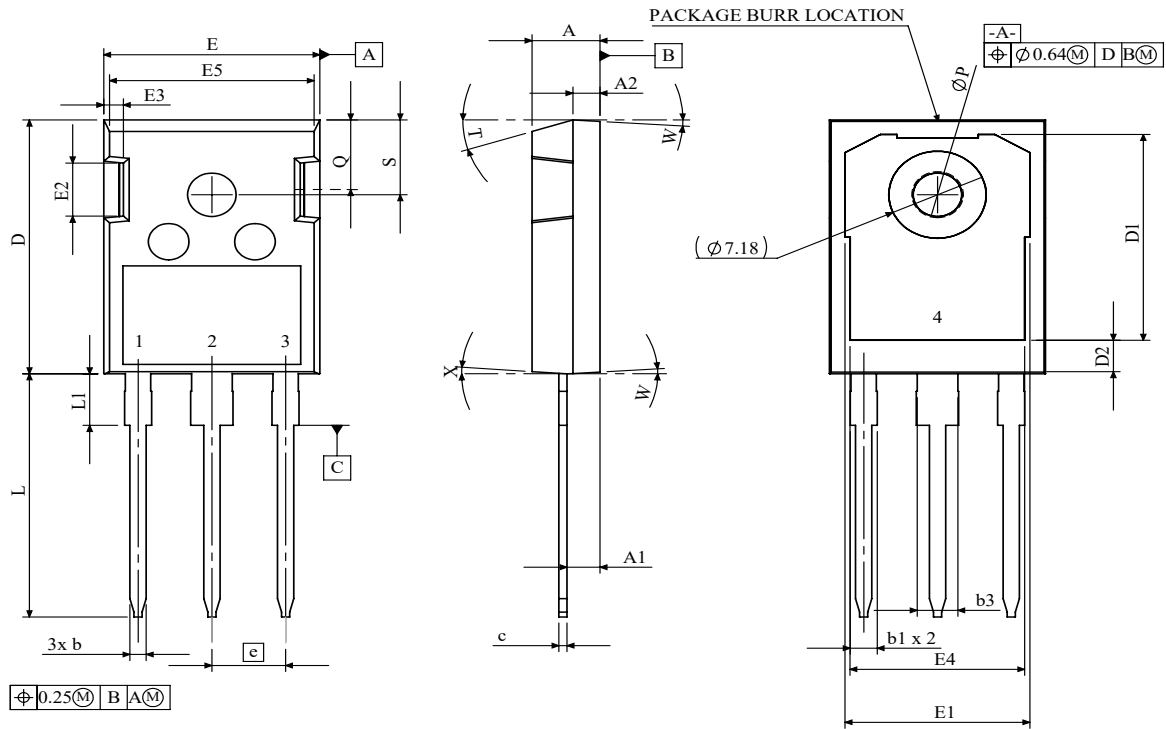


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Note:

³ Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

Package Dimensions – TO-247-4L


SYMBOL	MIN (mm)	MAX (mm)
A	4.83	5.21
A1	2.27	2.52
A2	1.91	2.16
b	1.07	1.33
b1	1.91	2.41
b3	2.87	3.38
c	0.55	0.74
D	20.75	21.05
D1	16	17.4
D2	2.86	3.26
E	15.75	16.13
E1	13.5	14.55
E2	3.68	5.1
E3	1	1.9
E4	12.38	13.43
E5	14.65	15.05
e	5.44 BSC	
L	19.73	20.48
L1	3.97	4.69
ØP	3.18	4.06
Q	5.42	5.96
S	5.85	6.49
T	17.5° REF.	
W	3.5° REF.	
X	4° REF.	

1	GATE
2	DRAIN
3	SOURCE
4	DRAIN

NOTES:

- ALL METAL SURFACES ARE TIN PLATED (MATTE), EXCEPT AREA OF CUT.
- DIMENSIONING & TOLERANCING CONFORM TO ASME Y14.5M-1994.
- ALL DIMENSIONS ARE LISTED IN MILLIMETERS. ANGLES ARE IN DEGREES.
- BURR OR MOLD FLASH SIZE (0.5 mm) IS NOT INCLUDED IN THE DIMENSIONS

Recommended Solder Pad Layout

